

# IMPORTANT NOTICE

10 December 2015

## 1. Global joint venture starts operations as WeEn Semiconductors

Dear customer,

As from November 9th, 2015 NXP Semiconductors N.V. and Beijing JianGuang Asset Management Co. Ltd established Bipolar Power joint venture (JV), **WeEn Semiconductors**, which will be used in future Bipolar Power documents together with new contact details.

In this document where the previous NXP references remain, please use the new links as shown below.

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Thank you for your cooperation and understanding,

WeEn Semiconductors

## 1. General description

Planar passivated high commutation three quadrant triac in a SOT54 (TO-92) plastic package. This "series B" triac is designed to commutate the full RMS current at the maximum junction temperature without the aid of a snubber.

## 2. Features and benefits

- 3Q technology for improved noise immunity
- High commutation capability with maximum false trigger immunity
- High voltage capability
- Less sensitive gate for highest noise immunity
- Planar passivated for voltage ruggedness and reliability
- Triggering in three quadrants only
- Very high immunity to false turn-on by dV/dt

## 3. Applications

- General purpose motor control
- Small loads in washing machines
- Solenoid drivers

## 4. Quick reference data

**Table 1. Quick reference data**

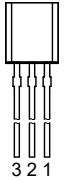
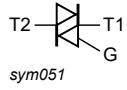
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	-	600	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{lead} \leq 54^\circ\text{C}$ ; <a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a>	-	-	1	A

### Static characteristics

$I_{GT}$	gate trigger current	$V_D = 12 \text{ V}$ ; $I_T = 0.1 \text{ A}$ ; T2+ G+; $T_j = 25^\circ\text{C}$ ; <a href="#">Fig. 7</a>	5	-	50	mA
		$V_D = 12 \text{ V}$ ; $I_T = 0.1 \text{ A}$ ; T2+ G-; $T_j = 25^\circ\text{C}$ ; <a href="#">Fig. 7</a>	5	-	50	mA
		$V_D = 12 \text{ V}$ ; $I_T = 0.1 \text{ A}$ ; T2- G-; $T_j = 25^\circ\text{C}$ ; <a href="#">Fig. 7</a>	5	-	50	mA

## 5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T2	main terminal 2	 <b>TO-92 (SOT54)</b>	 <i>sym051</i>
2	G	gate		
3	T1	main terminal 1		

## 6. Ordering information

Table 3. Ordering information

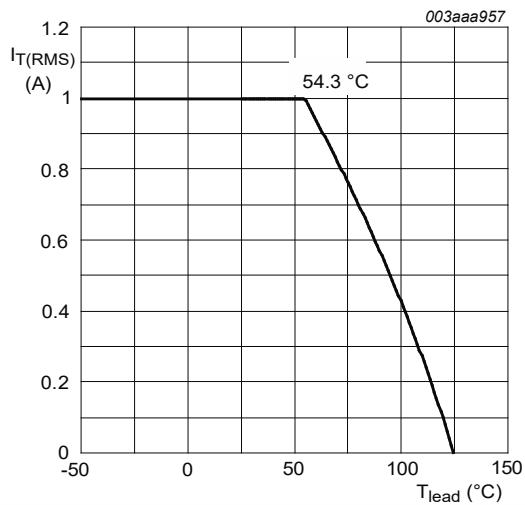
Type number	Package		
	Name	Description	Version
BTA201-600B	TO-92	plastic single-ended leaded (through hole) package; 3 leads	SOT54

## 7. Limiting values

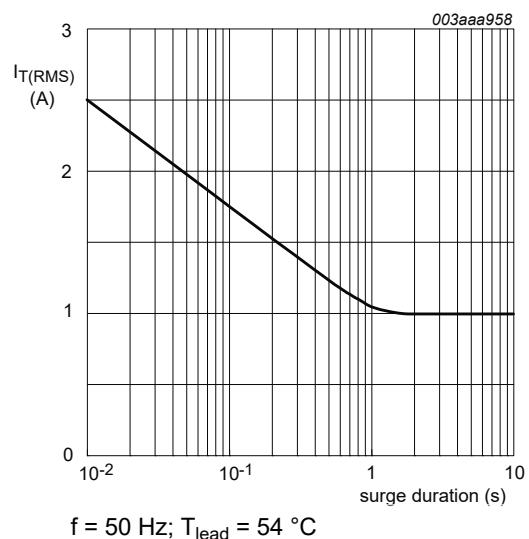
**Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage			-	600	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{lead} \leq 54^\circ\text{C}$ ; <a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a>		-	1	A
$I_{TSM}$	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25^\circ\text{C}$ ; $t_p = 16.8\text{ ms}$		-	13.7	A
		full sine wave; $T_{j(init)} = 25^\circ\text{C}$ ; $t_p = 20\text{ ms}$ ; <a href="#">Fig. 4</a> ; <a href="#">Fig. 5</a>		-	12.5	A
$I^2t$	$I^2t$ for fusing	$t_p = 10\text{ ms}$ ; SIN		-	0.78	$\text{A}^2\text{s}$
$dI_T/dt$	rate of rise of on-state current	$I_G = 0.2\text{ A}$		-	100	$\text{A}/\mu\text{s}$
$I_{GM}$	peak gate current			-	2	A
$P_{GM}$	peak gate power			-	5	W
$P_{G(AV)}$	average gate power	over any 20 ms period		-	0.1	W
$T_j$	junction temperature			-40	125	$^\circ\text{C}$



**Fig. 1. RMS on-state current as a function of lead temperature; maximum values**



**Fig. 2. RMS on-state current as a function of surge duration; maximum values**

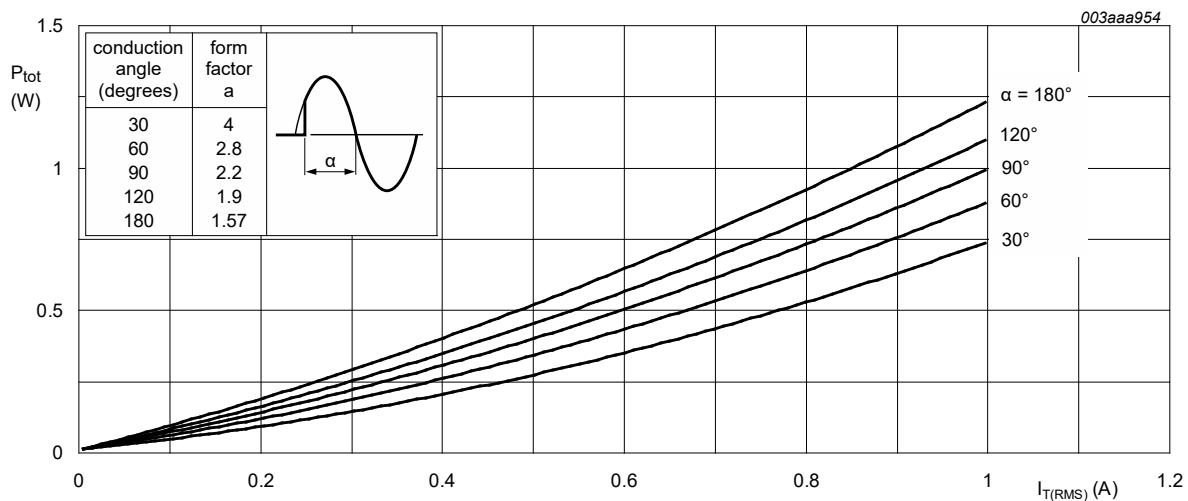


Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values

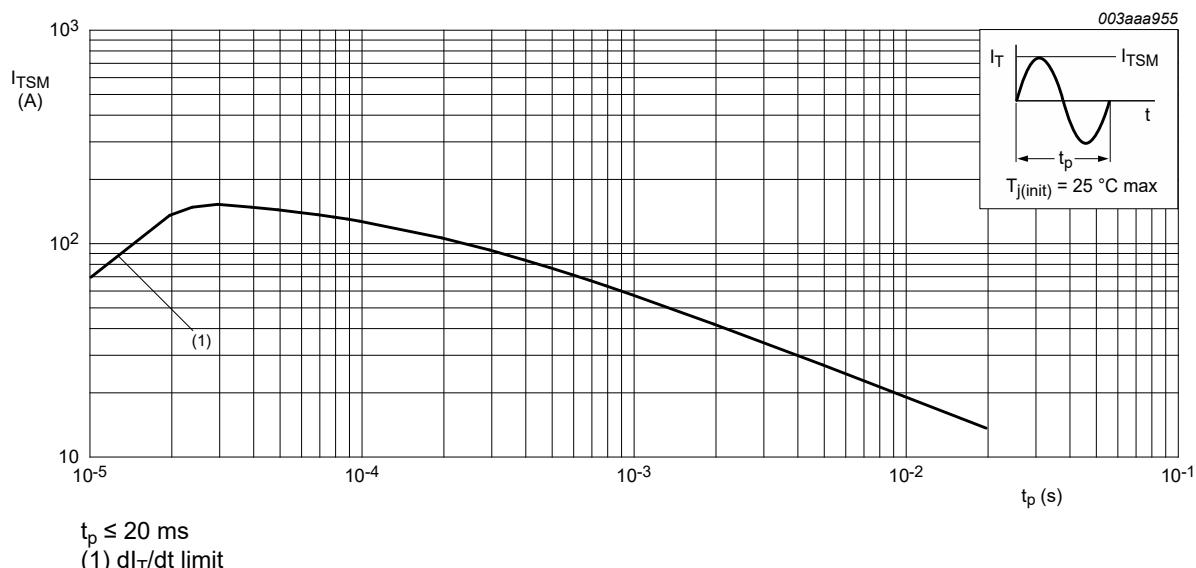
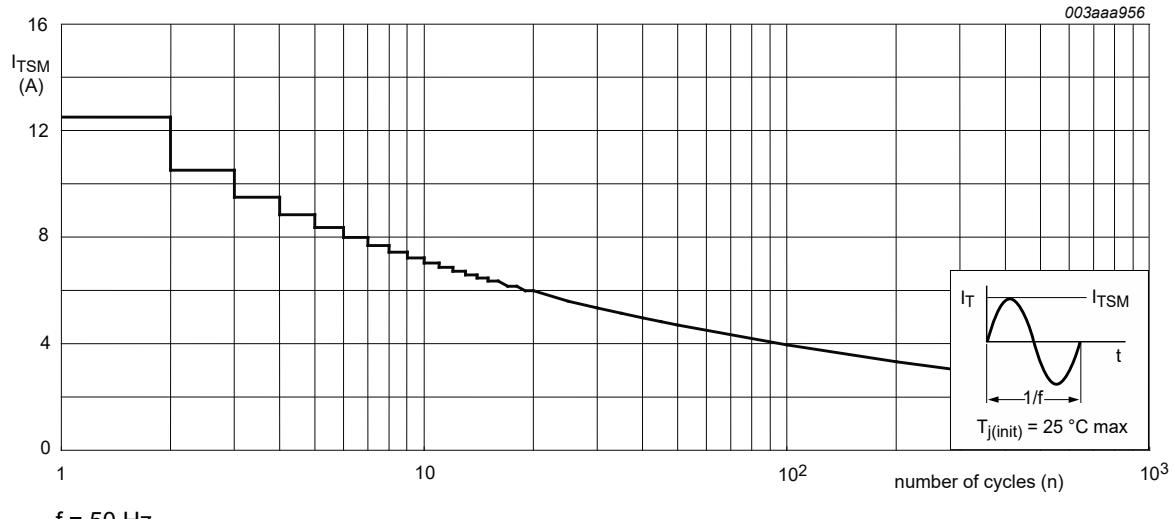


Fig. 4. Non-repetitive peak on-state current as a function of pulse width; maximum values

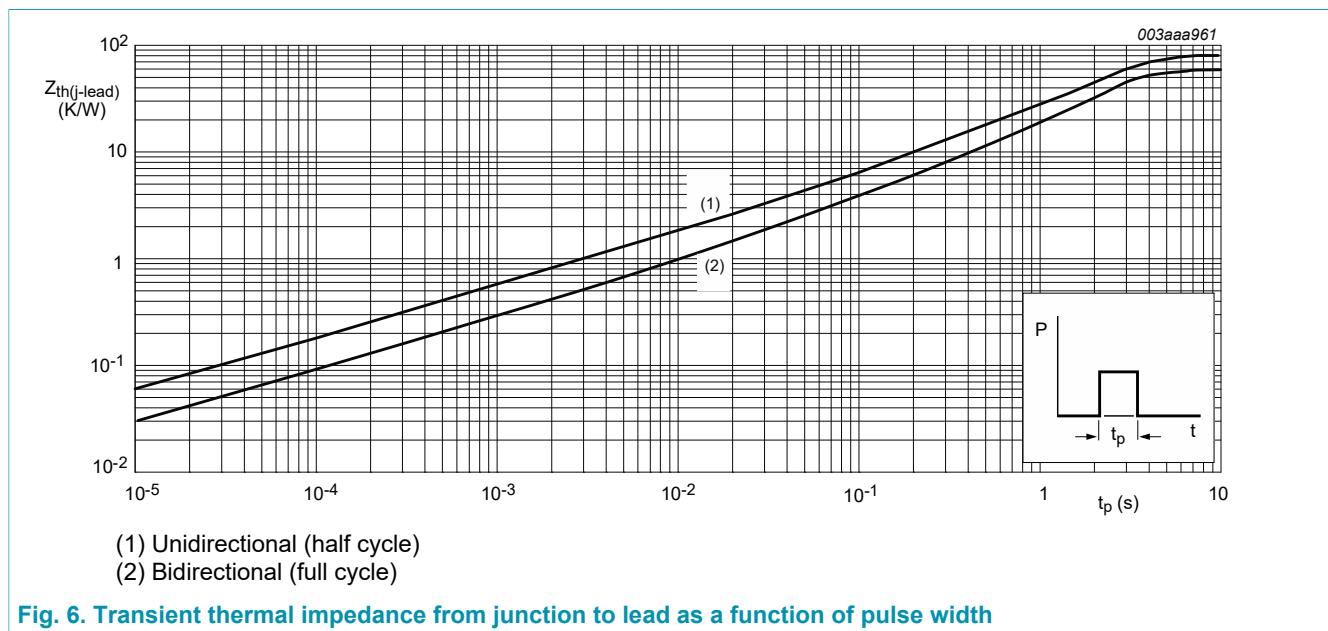


**Fig. 5. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values**

## 8. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-lead)}$	thermal resistance from junction to lead	full cycle; <a href="#">Fig. 6</a>	-	-	60	K/W
		half cycle; <a href="#">Fig. 6</a>	-	-	80	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient free air	printed circuit board mounted; lead length = 4 mm	-	150	-	K/W



## 9. Characteristics

**Table 6. Characteristics**

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
<b>Static characteristics</b>							
$I_{GT}$	gate trigger current	$V_D = 12 \text{ V}$ ; $I_T = 0.1 \text{ A}$ ; $T_2+ \text{ G+}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 7</a>		5	-	50	mA
		$V_D = 12 \text{ V}$ ; $I_T = 0.1 \text{ A}$ ; $T_2+ \text{ G-}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 7</a>		5	-	50	mA
		$V_D = 12 \text{ V}$ ; $I_T = 0.1 \text{ A}$ ; $T_2- \text{ G-}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 7</a>		5	-	50	mA
$I_L$	latching current	$V_D = 12 \text{ V}$ ; $I_G = 0.1 \text{ A}$ ; $T_2+ \text{ G+}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 8</a>		-	-	30	mA
		$V_D = 12 \text{ V}$ ; $I_G = 0.1 \text{ A}$ ; $T_2+ \text{ G-}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 8</a>		-	-	50	mA
		$V_D = 12 \text{ V}$ ; $I_G = 0.1 \text{ A}$ ; $T_2- \text{ G-}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 8</a>		-	-	30	mA
$I_H$	holding current	$V_D = 12 \text{ V}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 9</a>		-	-	30	mA
$V_T$	on-state voltage	$I_T = 1.4 \text{ A}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 10</a>		-	1.2	1.5	V
$V_{GT}$	gate trigger voltage	$V_D = 12 \text{ V}$ ; $I_T = 0.1 \text{ A}$ ; $T_j = 25 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 11</a>		-	0.7	1	V
		$V_D = 400 \text{ V}$ ; $I_T = 0.1 \text{ A}$ ; $T_j = 125 \text{ }^\circ\text{C}$ ; <a href="#">Fig. 11</a>		0.2	0.3	-	V
$I_D$	off-state current	$V_D = 600 \text{ V}$ ; $T_j = 125 \text{ }^\circ\text{C}$		-	0.1	0.5	mA
<b>Dynamic characteristics</b>							
$dV_D/dt$	rate of rise of off-state voltage	$V_{DM} = 402 \text{ V}$ ; $T_j = 125 \text{ }^\circ\text{C}$ ; ( $V_{DM} = 67\%$ of $V_{DRM}$ ); exponential waveform; gate open circuit; <a href="#">Fig. 12</a>		1000	-	-	V/ $\mu$ s
$dI_{com}/dt$	rate of change of commutating current	$V_D = 400 \text{ V}$ ; $T_j = 125 \text{ }^\circ\text{C}$ ; $I_{T(RMS)} = 1 \text{ A}$ ; $dV_{com}/dt = 20 \text{ V/s}$ ; (snubberless condition); gate open circuit		12	-	-	A/ms
		$V_D = 400 \text{ V}$ ; $T_j = 125 \text{ }^\circ\text{C}$ ; $I_{T(RMS)} = 1 \text{ A}$ ; $dV_{com}/dt = 10 \text{ V/\mus}$ ; gate open circuit		16	-	-	A/ms

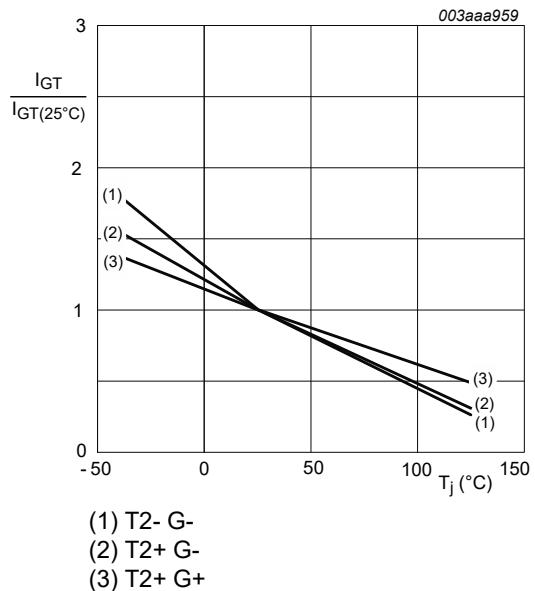


Fig. 7. Normalized gate trigger current as a function of junction temperature

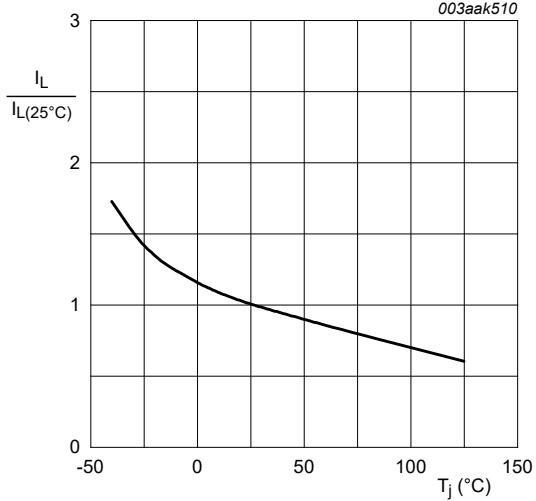


Fig. 8. Normalized latching current as a function of junction temperature

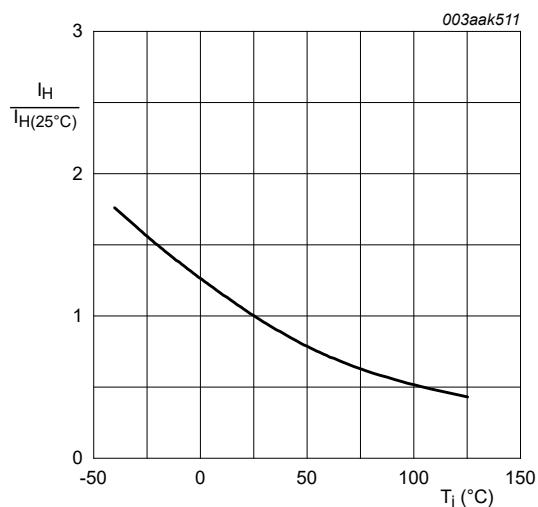
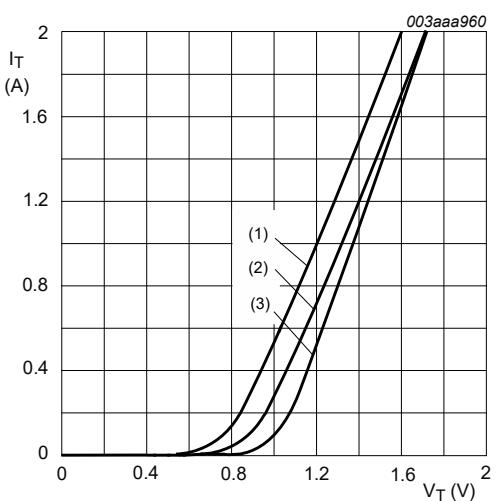


Fig. 9. Normalized holding current as a function of junction temperature



$V_O = 1.02 \text{ V}$ ;  $R_s = 0.358 \Omega$   
 (1)  $T_j = 125^{\circ}\text{C}$ ; typical values  
 (2)  $T_j = 125^{\circ}\text{C}$ ; maximum values  
 (3)  $T_j = 25^{\circ}\text{C}$ ; maximum values

Fig. 10. On-state current as a function of on-state voltage

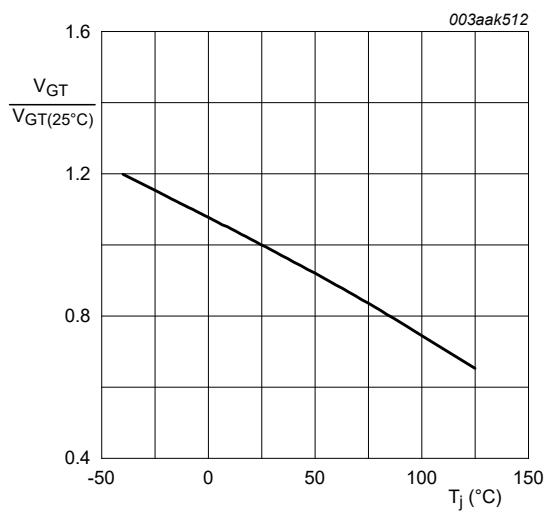


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

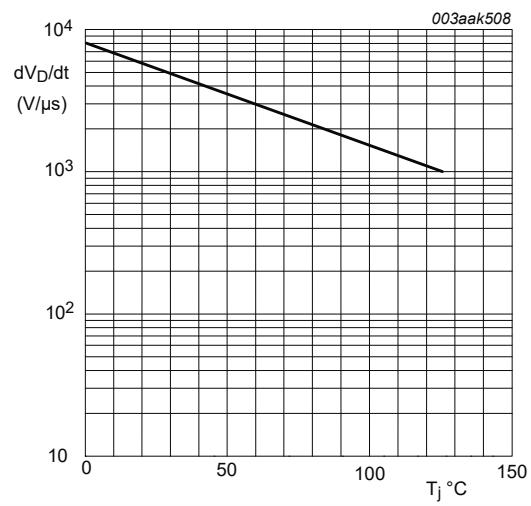
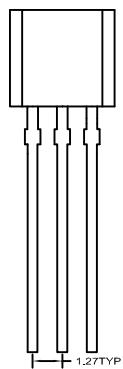


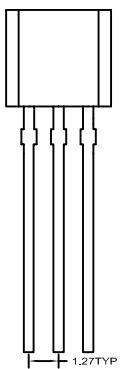
Fig. 12. Critical rate of rise of off-state voltage as a function of junction temperature; minimum values

## 10. Package outline

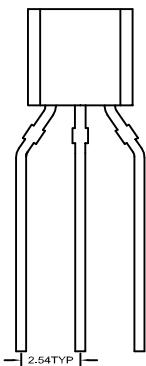
SOT54 PACKAGE OUTLINE



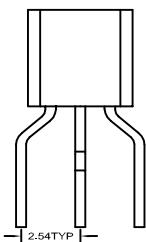
SOT54  
Bulk Pack - 412



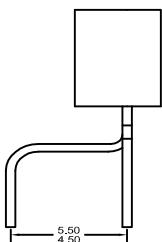
SOT54 LEADS ON CIRCLE  
Bulk Pack - 112



SOT54 WIDE PITCH  
Tape/ Reel Pack - 116  
Ammo Pack - 126



SOT54 LEAD BEND L01  
Bulk Pack - 412



SOT54 LEAD BEND L02  
Bulk Pack - 412

Remark: Detailed dimensions refer to POD drawing.

Fig. 13. Package outline TO-92 (SOT54)

## 11. Legal information

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Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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